### **Transaction Information**

Tool ID	A53x
Tool Status	Connected
Location	Burlington, USA
Wafer Size	200 mm
Fab Section	Metrology
Tool Available Date	2023-11-16

### **General Product Information**

Vendor Supplier	KLA-Tencor
Model	KLA-Tencor AIT
Vintage	1997
Serial No	0597-8087
Asset Description	Defect Inspection and Review for Semiconductors
Software Version	9.4
CIM	SECS, GEM
Process	Defect Inspection

## **Hardware Configuration (Fab)**

System Type	Description	Quantity	Status
Main System Defect Inspection		1	OK
Options System			
Others			

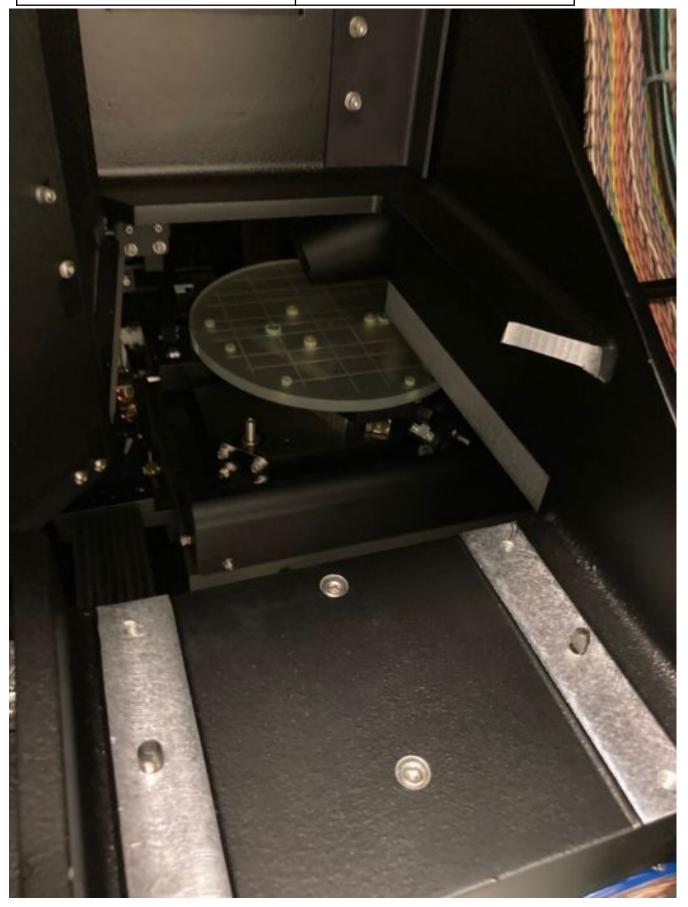
# Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NONE		

## Missing/Faulty Parts / Accesorries List

Description	Quantity
NONE	

## **Tool Pictures**

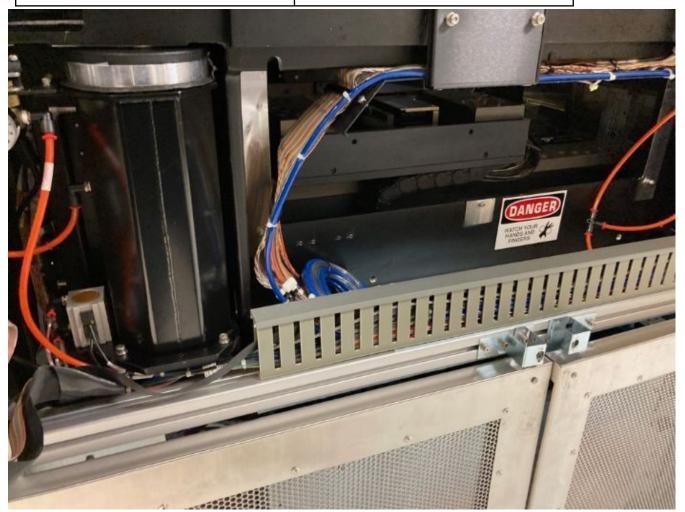
























## **Additional Tool Data Files**